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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Active
Number of LABs/CLBs	32575
Number of Logic Elements/Cells	416960
Total RAM Bits	30781440
Number of I/O	380
Number of Gates	-
Voltage - Supply	0.87V ~ 0.93V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 100°C (Tj)
Package / Case	900-BBGA, FCBGA
Supplier Device Package	901-FCBGA (31x31)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7k420t-l2ffv901e">https://www.e-xfl.com/product-detail/xilinx/xc7k420t-l2ffv901e</a>

Table 1: Absolute Maximum Ratings (1) (Cont'd)

Symbol	Description	Min	Max	Units
I <sub>DCIN</sub>	DC input current for receiver input pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
I <sub>DCOUT</sub>	DC output current for transmitter pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
<b>XADC</b>				
V <sub>CCADC</sub>	XADC supply relative to GNDADC	–0.5	2.0	V
V <sub>REFP</sub>	XADC reference input relative to GNDADC	–0.5	2.0	V
<b>Temperature</b>				
T <sub>STG</sub>	Storage temperature (ambient)	–65	150	°C
T <sub>SOL</sub>	Maximum soldering temperature for Pb/Sn component bodies (6)	–	+220	°C
	Maximum soldering temperature for Pb-free component bodies (6)	–	+260	°C
T <sub>j</sub>	Maximum junction temperature(6)	–	+125	°C

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
- The lower absolute voltage specification always applies.
- For I/O operation, refer to [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).
- The maximum limit applied to DC and AC signals.
- For maximum undershoot and overshoot AC specifications, see [Table 4](#) and [Table 5](#).
- For soldering guidelines and thermal considerations, see [UG475: 7 Series FPGA Packaging and Pinout Specification](#).

Table 2: Recommended Operating Conditions (1)

Symbol	Description	Min	Typ	Max	Units
<b>FPGA Logic</b>					
V <sub>CCINT</sub> <sup>(2)</sup>	Internal supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: internal supply voltage	0.87	0.90	0.93	V
V <sub>CCBRAM</sub> <sup>(2)</sup>	Block RAM supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: block RAM supply voltage	0.87	0.90	1.03	V
V <sub>CCAUX</sub>	Auxiliary supply voltage	1.71	1.80	1.89	V
V <sub>CCO</sub> <sup>(3)(4)</sup>	Supply voltage for 3.3V HR I/O banks	1.14	–	3.465	V
	Supply voltage for 1.8V HP I/O banks	1.14	–	1.89	V
V <sub>CCAUX_IO</sub>	Auxiliary supply voltage when set to 1.8V	1.71	1.80	1.89	V
	Auxiliary supply voltage when set to 2.0V	1.94	2.00	2.06	V
V <sub>IN</sub> <sup>(5)</sup>	I/O input voltage	–0.20	–	V <sub>CCO</sub> + 0.2	V
	I/O input voltage for V <sub>REF</sub> and differential I/O standards	–0.20	–	2.625	V
I <sub>IN</sub> <sup>(6)</sup>	Maximum current through any pin in a powered or unpowered bank when forward biasing the clamp diode.	–	–	10	mA
V <sub>CCBATT</sub> <sup>(7)</sup>	Battery voltage	1.0	–	1.89	V
<b>GTX Transceiver</b>					
V <sub>MGTAVCC</sub> <sup>(8)</sup>	Analog supply voltage for the GTX transceiver QPLL frequency range ≤ 10.3125 GHz <sup>(9)(10)</sup>	0.97	1.0	1.08	V
	Analog supply voltage for the GTX transceiver QPLL frequency range > 10.3125 GHz	1.02	1.05	1.08	V
V <sub>MGTAVTT</sub> <sup>(8)</sup>	Analog supply voltage for the GTX transmitter and receiver termination circuits	1.17	1.2	1.23	V
V <sub>MGTVCaux</sub> <sup>(8)</sup>	Auxiliary analog QPLL voltage supply for the transceivers	1.75	1.80	1.85	V

**Table 3: DC Characteristics Over Recommended Operating Conditions (Cont'd)**

Symbol	Description	Min	Typ <sup>(1)</sup>	Max	Units
R <sub>IN_TERM</sub> <sup>(4)</sup>	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_40) for commercial (C), industrial (I), and extended (E) temperature devices	28	40	55	Ω
	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_50) for commercial (C), industrial (I), and extended (E) temperature devices	35	50	65	Ω
	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_60) for commercial (C), industrial (I), and extended (E) temperature devices	44	60	83	Ω
n	Temperature diode ideality factor	—	1.010	—	—
r	Temperature diode series resistance	—	2	—	Ω

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. This measurement represents the die capacitance at the pad, not including the package.
3. Maximum value specified for worst case process at 25°C.
4. Termination resistance to a V<sub>CCO</sub>/2 level.

**Table 4: Maximum Allowed AC Voltage Overshoot and Undershoot for 3.3V HR I/O Banks<sup>(1)</sup>**

AC Voltage Overshoot	% of UI @-40°C to 100°C	AC Voltage Undershoot	% of UI @-40°C to 100°C
V <sub>CCO</sub> + 0.40	100	-0.40	100
V <sub>CCO</sub> + 0.45	100	-0.45	61.7
V <sub>CCO</sub> + 0.50	100	-0.50	25.8
V <sub>CCO</sub> + 0.55	100	-0.55	11.0
V <sub>CCO</sub> + 0.60	46.6	-0.60	4.77
V <sub>CCO</sub> + 0.65	21.2	-0.65	2.10
V <sub>CCO</sub> + 0.70	9.75	-0.70	0.94
V <sub>CCO</sub> + 0.75	4.55	-0.75	0.43
V <sub>CCO</sub> + 0.80	2.15	-0.80	0.20
V <sub>CCO</sub> + 0.85	1.02	-0.85	0.09
V <sub>CCO</sub> + 0.90	0.49	-0.90	0.04
V <sub>CCO</sub> + 0.95	0.24	-0.95	0.02

**Notes:**

1. A total of 200 mA per bank should not be exceeded.

**Table 5: Maximum Allowed AC Voltage Overshoot and Undershoot for 1.8V HP I/O Banks<sup>(1)(2)</sup>**

AC Voltage Overshoot	% of UI @-40°C to 100°C	AC Voltage Undershoot	% of UI @-40°C to 100°C
V <sub>CCO</sub> + 0.40	100	-0.40	100
V <sub>CCO</sub> + 0.45	100	-0.45	100
V <sub>CCO</sub> + 0.50	100	-0.50	100
V <sub>CCO</sub> + 0.55	100	-0.55	100
V <sub>CCO</sub> + 0.60	50.0	-0.60	50.0
V <sub>CCO</sub> + 0.65	50.0	-0.65	50.0
V <sub>CCO</sub> + 0.70	47.0	-0.70	50.0
V <sub>CCO</sub> + 0.75	21.2	-0.75	50.0

Table 10: Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OCM</sub> <sup>(3)</sup>			V <sub>OD</sub> <sup>(4)</sup>		
	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max
BLVDS_25	0.300	1.200	1.425	0.100	—	—	—	1.250	—	Note 5		
MINI_LVDS_25	0.300	1.200	V <sub>CCAUX</sub>	0.200	0.400	0.600	1.000	1.200	1.400	0.300	0.450	0.600
PPDS_25	0.200	0.900	V <sub>CCAUX</sub>	0.100	0.250	0.400	0.500	0.950	1.400	0.100	0.250	0.400
RSDS_25	0.300	0.900	1.500	0.100	0.350	0.600	1.000	1.200	1.400	0.100	0.350	0.600
TMDS_33	2.700	2.965	3.230	0.150	0.675	1.200	V <sub>CCO</sub> –0.405	V <sub>CCO</sub> –0.300	V <sub>CCO</sub> –0.190	0.400	0.600	0.800

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OCM</sub> is the output common mode voltage.
4. V<sub>OD</sub> is the output differential voltage (Q –  $\bar{Q}$ ).
5. V<sub>OD</sub> for BLVDS will vary significantly depending on topology and loading.
6. LVDS\_25 is specified in Table 12.
7. LVDS is specified in Table 13.

Table 11: Complementary Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OL</sub> <sup>(3)</sup>		V <sub>OH</sub> <sup>(4)</sup>		I <sub>OL</sub>		I <sub>OH</sub>
	V, Min	V, Typ	V, Max	V, Min	V, Max	V, Max	V, Min	mA, Max	mA, Min	V, Min	mA, Max	mA, Min	
DIFF_HSTL_I	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	—8.00				
DIFF_HSTL_I_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	—8.00				
DIFF_HSTL_II	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	—16.00				
DIFF_HSTL_II_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	—16.00				
DIFF_HSUL_12	0.300	0.600	0.850	0.100	—	20% V <sub>CCO</sub>	80% V <sub>CCO</sub>	0.100	—0.100				
DIFF_MOBILE_DDR	0.300	0.900	1.425	0.100	—	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	0.100	—0.100				
DIFF_SSTL12	0.300	0.600	0.850	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	14.25	—14.25				
DIFF_SSTL135	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	13.0	—13.0				
DIFF_SSTL135_R	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	8.9	—8.9				
DIFF_SSTL15	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	13.0	—13.0				
DIFF_SSTL15_R	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	8.9	—8.9				
DIFF_SSTL18_I	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.470	(V <sub>CCO</sub> /2) + 0.470	8.00	—8.00				
DIFF_SSTL18_II	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.600	(V <sub>CCO</sub> /2) + 0.600	13.4	—13.4				

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OL</sub> is the single-ended low-output voltage.
4. V<sub>OH</sub> is the single-ended high-output voltage.

## LVDS DC Specifications (LVDS\_25)

The LVDS\_25 standard is available in the HR I/O banks. See [UG471: 7 Series FPGAs SelectIO Resources User Guide](#) for more information.

**Table 12: LVDS\_25 DC Specifications**

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		2.375	2.500	2.625	V
$V_{OH}$	Output High Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.700	–	–	V
$V_{ODIFF}$	Differential Output Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output Common-Mode Voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential Input Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High		100	350	600	mV
$V_{ICM}$	Input Common-Mode Voltage		0.300	1.200	1.425	V

## LVDS DC Specifications (LVDS)

The LVDS standard is available in the HP I/O banks. See [UG471: 7 Series FPGAs SelectIO Resources User Guide](#) for more information.

**Table 13: LVDS DC Specifications**

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		1.710	1.800	1.890	V
$V_{OH}$	Output High Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.825	–	–	V
$V_{ODIFF}$	Differential Output Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output Common-Mode Voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential Input Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	Common-mode input voltage = 1.25V	100	350	600	mV
$V_{ICM}$	Input Common-Mode Voltage	Differential input voltage = $\pm 350$ mV	0.300	1.200	1.425	V

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases.

**Table 15** lists the production released Kintex-7 device, speed grade, and the minimum corresponding supported speed specification version and ISE software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

**Table 15: Kintex-7 Device Production Software and Speed Specification Release**

Device	Speed Grade Designations			
	1.0V		0.9V	
	-3	-2/-2L	-1	-2L
XC7K70T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K160T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K325T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K355T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K410T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K420T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K480T		ISE 14.2 v1.06		ISE 14.3 v1.06

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Kintex-7 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [AC Switching Characteristics, page 11](#). In each table, the I/O bank type is either High Performance (HP) or High Range (HR).

**Table 16: Networking Applications Interface Performances**

Description	I/O Bank Type	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	

### Notes:

- LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
HSTL_I_F	0.61	0.64	0.73	0.79	1.10	1.19	1.23	1.41	1.86	2.05	2.22	1.92	ns	
HSTL_II_F	0.61	0.64	0.73	0.78	1.05	1.18	1.28	1.42	1.81	2.04	2.27	1.94	ns	
HSTL_I_18_F	0.64	0.67	0.76	0.79	1.05	1.18	1.28	1.44	1.81	2.04	2.27	1.95	ns	
HSTL_II_18_F	0.64	0.67	0.76	0.79	1.03	1.14	1.23	1.42	1.79	2.00	2.22	1.94	ns	
DIFF_HSTL_I_F	0.63	0.67	0.77	0.78	1.09	1.18	1.22	1.48	1.85	2.04	2.21	2.00	ns	
DIFF_HSTL_II_F	0.63	0.67	0.77	0.79	1.02	1.11	1.14	1.48	1.78	1.97	2.13	2.00	ns	
DIFF_HSTL_I_18_F	0.65	0.69	0.78	0.79	1.08	1.17	1.21	1.48	1.84	2.03	2.20	2.00	ns	
DIFF_HSTL_II_18_F	0.65	0.69	0.78	0.81	1.01	1.10	1.13	1.48	1.77	1.96	2.12	2.00	ns	
LVCMOS33_S4	1.31	1.40	1.60	1.54	5.23	5.61	6.09	4.13	5.99	6.47	7.08	4.64	ns	
LVCMOS33_S8	1.31	1.40	1.60	1.54	4.46	4.85	5.33	3.84	5.22	5.71	6.32	4.36	ns	
LVCMOS33_S12	1.31	1.40	1.60	1.54	3.46	3.89	4.42	3.41	4.22	4.75	5.41	3.92	ns	
LVCMOS33_S16	1.31	1.40	1.60	1.54	3.06	3.43	3.88	3.72	3.82	4.29	4.87	4.23	ns	
LVCMOS33_F4	1.31	1.40	1.60	1.54	4.70	5.01	5.36	3.58	5.46	5.87	6.35	4.09	ns	
LVCMOS33_F8	1.31	1.40	1.60	1.54	3.62	4.04	4.56	3.06	4.38	4.90	5.55	3.58	ns	
LVCMOS33_F12	1.31	1.40	1.60	1.54	2.57	2.85	3.15	2.88	3.33	3.71	4.14	3.39	ns	
LVCMOS33_F16	1.31	1.40	1.60	1.54	2.44	2.69	2.96	2.88	3.20	3.55	3.95	3.39	ns	
LVCMOS25_S4	1.08	1.16	1.32	1.36	4.49	4.80	5.16	3.44	5.25	5.66	6.15	3.95	ns	
LVCMOS25_S8	1.08	1.16	1.32	1.36	3.66	4.04	4.49	3.20	4.42	4.90	5.48	3.72	ns	
LVCMOS25_S12	1.08	1.16	1.32	1.36	2.77	3.10	3.49	2.80	3.53	3.96	4.48	3.31	ns	
LVCMOS25_S16	1.08	1.16	1.32	1.36	3.24	3.62	4.09	3.14	4.00	4.48	5.08	3.66	ns	
LVCMOS25_F4	1.08	1.16	1.32	1.36	3.96	4.31	4.72	3.06	4.72	5.17	5.71	3.58	ns	
LVCMOS25_F8	1.08	1.16	1.32	1.36	2.43	2.87	3.42	2.50	3.19	3.73	4.41	3.02	ns	
LVCMOS25_F12	1.08	1.16	1.32	1.36	2.23	2.63	3.13	2.48	2.99	3.49	4.12	3.00	ns	
LVCMOS25_F16	1.08	1.16	1.32	1.36	1.92	2.17	2.45	2.33	2.68	3.03	3.44	2.84	ns	
LVCMOS18_S4	0.64	0.66	0.74	0.87	3.24	3.45	3.66	1.91	4.00	4.31	4.65	2.42	ns	
LVCMOS18_S8	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns	
LVCMOS18_S12	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns	
LVCMOS18_S16	0.64	0.66	0.74	0.87	1.82	2.03	2.24	1.84	2.58	2.89	3.23	2.36	ns	
LVCMOS18_S24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.74	1.92	2.08	1.92	2.50	2.78	3.07	2.44	ns	
LVCMOS18_F4	0.64	0.66	0.74	0.87	3.12	3.31	3.49	1.77	3.88	4.17	4.48	2.28	ns	
LVCMOS18_F8	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns	
LVCMOS18_F12	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns	
LVCMOS18_F16	0.64	0.66	0.74	0.87	1.52	1.68	1.81	1.72	2.28	2.54	2.80	2.23	ns	
LVCMOS18_F24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.34	1.46	1.55	1.66	2.10	2.32	2.54	2.17	ns	
LVCMOS15_S4	0.66	0.69	0.81	0.90	3.48	3.74	4.03	2.22	4.24	4.60	5.02	2.73	ns	
LVCMOS15_S8	0.66	0.69	0.81	0.90	2.37	2.67	3.01	2.41	3.13	3.53	4.00	2.92	ns	
LVCMOS15_S12	0.66	0.69	0.81	0.90	1.83	2.03	2.23	1.91	2.59	2.89	3.22	2.42	ns	

Table 20: 1.8V IOB High Performance (HP) Switching Characteristics

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVDS	0.75	0.79	0.92	0.89	1.05	1.17	1.24	1.43	1.68	1.92	2.06	2.04	ns	
HSUL_12	0.69	0.72	0.82	0.95	1.65	1.84	2.05	1.80	2.29	2.59	2.87	2.41	ns	
DIFF_HSUL_12	0.69	0.72	0.82	0.92	1.65	1.84	2.05	1.47	2.29	2.59	2.87	2.08	ns	
HSTL_I_S	0.68	0.72	0.82	0.84	1.15	1.28	1.38	1.46	1.79	2.03	2.20	2.07	ns	
HSTL_II_S	0.68	0.72	0.82	0.84	1.05	1.17	1.26	1.44	1.69	1.93	2.08	2.05	ns	
HSTL_I_18_S	0.70	0.72	0.82	0.86	1.12	1.24	1.34	1.41	1.75	2.00	2.16	2.02	ns	
HSTL_II_18_S	0.70	0.72	0.82	0.86	1.06	1.18	1.26	1.44	1.70	1.94	2.08	2.05	ns	
HSTL_I_12_S	0.68	0.72	0.82	0.94	1.14	1.27	1.37	1.43	1.78	2.02	2.20	2.04	ns	
HSTL_I_DCI_S	0.68	0.72	0.82	0.78	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns	
HSTL_II_DCI_S	0.68	0.72	0.82	0.78	1.05	1.17	1.26	1.33	1.69	1.93	2.08	1.94	ns	
HSTL_II_T_DCI_S	0.70	0.72	0.82	0.76	1.15	1.28	1.38	1.40	1.78	2.03	2.20	2.01	ns	
HSTL_I_DCI_18_S	0.70	0.72	0.82	0.76	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns	
HSTL_II_DCI_18_S	0.70	0.72	0.82	0.76	1.05	1.16	1.24	1.32	1.69	1.92	2.06	1.93	ns	
HSTL_II_T_DCI_18_S	0.70	0.72	0.82	0.76	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns	
DIFF_HSTL_I_S	0.75	0.79	0.92	0.89	1.15	1.28	1.38	1.47	1.79	2.03	2.20	2.08	ns	
DIFF_HSTL_II_S	0.75	0.79	0.92	0.89	1.05	1.17	1.26	1.47	1.69	1.93	2.08	2.08	ns	
DIFF_HSTL_I_DCI_S	0.75	0.79	0.92	0.76	1.15	1.28	1.38	1.47	1.78	2.03	2.20	2.08	ns	
DIFF_HSTL_II_DCI_S	0.75	0.79	0.92	0.76	1.05	1.17	1.26	1.40	1.69	1.93	2.08	2.01	ns	
DIFF_HSTL_I_18_S	0.75	0.79	0.92	0.89	1.12	1.24	1.34	1.46	1.75	2.00	2.16	2.07	ns	
DIFF_HSTL_II_18_S	0.75	0.79	0.92	0.89	1.06	1.18	1.26	1.47	1.70	1.94	2.08	2.08	ns	
DIFF_HSTL_I_DCI_18_S	0.75	0.79	0.92	0.75	1.11	1.23	1.33	1.46	1.74	1.99	2.15	2.07	ns	
DIFF_HSTL_II_DCI_18_S	0.75	0.79	0.92	0.75	1.05	1.16	1.24	1.41	1.69	1.92	2.06	2.02	ns	
DIFF_HSTL_II_T_DCI_18_S	0.75	0.79	0.92	0.76	1.11	1.23	1.33	1.46	1.74	1.99	2.15	2.07	ns	
HSTL_I_F	0.68	0.72	0.82	0.84	1.02	1.14	1.22	1.26	1.66	1.90	2.04	1.87	ns	
HSTL_II_F	0.68	0.72	0.82	0.84	0.97	1.08	1.15	1.29	1.61	1.84	1.97	1.90	ns	
HSTL_I_18_F	0.70	0.72	0.82	0.86	1.04	1.16	1.24	1.32	1.68	1.91	2.06	1.93	ns	
HSTL_II_18_F	0.70	0.72	0.82	0.86	0.98	1.09	1.16	1.35	1.62	1.85	1.98	1.96	ns	
HSTL_I_12_F	0.68	0.72	0.82	0.94	1.02	1.13	1.21	1.26	1.65	1.88	2.03	1.87	ns	
HSTL_I_DCI_F	0.68	0.72	0.82	0.78	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns	
HSTL_II_DCI_F	0.68	0.72	0.82	0.78	0.97	1.08	1.15	1.22	1.61	1.84	1.97	1.83	ns	
HSTL_II_T_DCI_F	0.70	0.72	0.82	0.76	1.02	1.14	1.22	1.26	1.66	1.90	2.04	1.87	ns	
HSTL_I_DCI_18_F	0.70	0.72	0.82	0.76	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns	
HSTL_II_DCI_18_F	0.70	0.72	0.82	0.76	0.98	1.09	1.16	1.27	1.61	1.85	1.98	1.88	ns	
HSTL_II_T_DCI_18_F	0.70	0.72	0.82	0.76	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns	
DIFF_HSTL_I_F	0.75	0.79	0.92	0.89	1.02	1.14	1.22	1.35	1.66	1.90	2.04	1.96	ns	
DIFF_HSTL_II_F	0.75	0.79	0.92	0.89	0.97	1.08	1.15	1.35	1.61	1.84	1.97	1.96	ns	
DIFF_HSTL_I_DCI_F	0.75	0.79	0.92	0.76	1.02	1.14	1.22	1.35	1.66	1.90	2.04	1.96	ns	

## Input/Output Logic Switching Characteristics

Table 22: ILOGIC Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
T <sub>ICE1CK/T<sub>ICKCE1</sub></sub>	CE1 pin Setup/Hold with respect to CLK	0.42/0.00	0.48/0.00	0.67/0.00	0.56/-0.16	ns
T <sub>ISRCK/T<sub>ICKSR</sub></sub>	SR pin Setup/Hold with respect to CLK	0.53/0.01	0.61/0.01	0.99/0.01	0.88/-0.30	ns
T <sub>IDOCKE2/T<sub>IOCKDE2</sub></sub>	D pin Setup/Hold with respect to CLK without Delay (HP I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	0.01/0.41	ns
T <sub>IDOCKDE2/T<sub>IOCKDDE2</sub></sub>	DDLY pin Setup/Hold with respect to CLK (using IDELAY) (HP I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	0.01/0.41	ns
T <sub>IDOCKE3/T<sub>IOCKDE3</sub></sub>	D pin Setup/Hold with respect to CLK without Delay (HR I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	0.01/0.41	ns
T <sub>IDOCKDE3/T<sub>IOCKDDE3</sub></sub>	DDLY pin Setup/Hold with respect to CLK (using IDELAY) (HR I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	0.01/0.41	ns
<b>Combinatorial</b>						
T <sub>IDIE2</sub>	D pin to O pin propagation delay, no Delay (HP I/O banks only)	0.09	0.10	0.12	0.14	ns
T <sub>IDIDE2</sub>	DDLY pin to O pin propagation delay (using IDELAY) (HP I/O banks only)	0.10	0.11	0.13	0.15	ns
T <sub>IDIE3</sub>	D pin to O pin propagation delay, no Delay (HR I/O banks only)	0.09	0.10	0.12	0.14	ns
T <sub>IDIDE3</sub>	DDLY pin to O pin propagation delay (using IDELAY) (HR I/O banks only)	0.10	0.11	0.13	0.15	ns
<b>Sequential Delays</b>						
T <sub>IDLOE2</sub>	D pin to Q1 pin using flip-flop as a latch without Delay (HP I/O banks only)	0.36	0.39	0.45	0.54	ns
T <sub>IDLODE2</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HP I/O banks only)	0.36	0.39	0.45	0.55	ns
T <sub>IDLOE3</sub>	D pin to Q1 pin using flip-flop as a latch without Delay (HR I/O banks only)	0.36	0.39	0.45	0.54	ns
T <sub>IDLODE3</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HR I/O banks only)	0.36	0.39	0.45	0.55	ns
T <sub>ICKQ</sub>	CLK to Q outputs	0.47	0.50	0.58	0.71	ns
T <sub>RQ_ILOGICE2</sub>	SR pin to OQ/TQ out (HP I/O banks only)	0.84	0.94	1.16	1.32	ns
T <sub>GSRQ_ILOGICE2</sub>	Global Set/Reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	11.39	ns
T <sub>RQ_ILOGICE3</sub>	SR pin to OQ/TQ out (HR I/O banks only)	0.84	0.94	1.16	1.32	ns
T <sub>GSRQ_ILOGICE3</sub>	Global Set/Reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	11.39	ns
<b>Set/Reset</b>						
T <sub>RPW_ILOGICE2</sub>	Minimum Pulse Width, SR inputs (HP I/O banks only)	0.54	0.63	0.63	0.68	ns, Min
T <sub>RPW_ILOGICE3</sub>	Minimum Pulse Width, SR inputs (HR I/O banks only)	0.54	0.63	0.63	0.68	ns, Min

## Block RAM and FIFO Switching Characteristics

Table 31: Block RAM and FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Block RAM and FIFO Clock-to-Out Delays</b>						
T <sub>RCKO_DO</sub> and T <sub>RCKO_DO_REG</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2)(3)</sup>	1.57	1.80	2.08	2.44	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4)(5)</sup>	0.54	0.63	0.75	0.86	ns, Max
T <sub>RCKO_DO_ECC</sub> and T <sub>RCKO_DO_ECC_REG</sub>	Clock CLK to DOUT output with ECC (without output register) <sup>(2)(3)</sup>	2.35	2.58	3.26	4.49	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4)(5)</sup>	0.62	0.69	0.80	0.94	ns, Max
T <sub>RCKO_DO_CASCOUP</sub> and T <sub>RCKO_DO_CASCOUP_REG</sub>	Clock CLK to DOUT output with Cascade (without output register) <sup>(2)</sup>	2.21	2.45	2.80	3.19	ns, Max
	Clock CLK to DOUT output with Cascade (with output register) <sup>(4)</sup>	0.98	1.08	1.24	1.32	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.65	0.74	0.89	0.97	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointers outputs <sup>(7)</sup>	0.79	0.87	0.98	1.10	ns, Max
T <sub>RCKO_PARITY_ECC</sub>	Clock CLK to ECCPARITY in ECC encode only mode	0.66	0.72	0.80	0.93	ns, Max
T <sub>RCKO_SDBIT_ECC</sub> and T <sub>RCKO_SDBIT_ECC_REG</sub>	Clock CLK to BITERR (without output register)	2.17	2.38	3.01	4.15	ns, Max
	Clock CLK to BITERR (with output register)	0.57	0.65	0.76	0.89	ns, Max
T <sub>RCKO_RDADDR_ECC</sub> and T <sub>RCKO_RDADDR_ECC_REG</sub>	Clock CLK to RDADDR output with ECC (without output register)	0.64	0.74	0.90	0.98	ns, Max
	Clock CLK to RDADDR output with ECC (with output register)	0.71	0.79	0.92	1.10	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>RCKC_ADDRA</sub> /T <sub>RCKC_ADDRA</sub>	ADDR inputs <sup>(8)</sup>	0.38/0.27	0.42/0.28	0.48/0.31	0.65/0.38	ns, Min
T <sub>RDCK_DI_WF_NC</sub> / T <sub>RCKD_DI_WF_NC</sub>	Data input setup/hold time when block RAM is configured in WRITE_FIRST or NO_CHANGE mode <sup>(9)</sup>	0.49/0.51	0.55/0.53	0.63/0.57	0.78/0.64	ns, Min
T <sub>RDCK_DI_RF</sub> /T <sub>RCKD_DI_RF</sub>	Data input setup/hold time when block RAM is configured in READ_FIRST mode <sup>(9)</sup>	0.17/0.25	0.19/0.29	0.21/0.35	0.25/0.32	ns, Min
T <sub>RDCK_DI_ECC</sub> / T <sub>RCKD_DI_ECC</sub>	DIN inputs with block RAM ECC in standard mode <sup>(9)</sup>	0.42/0.37	0.47/0.39	0.53/0.43	0.66/0.46	ns, Min
T <sub>RDCK_DI_ECCW</sub> / T <sub>RCKD_DI_ECCW</sub>	DIN inputs with block RAM ECC encode only <sup>(9)</sup>	0.79/0.37	0.87/0.39	0.99/0.43	1.17/0.41	ns, Min
T <sub>RDCK_DI_ECC_FIFO</sub> / T <sub>RCKD_DI_ECC_FIFO</sub>	DIN inputs with FIFO ECC in standard mode <sup>(9)</sup>	0.89/0.47	0.98/0.50	1.12/0.54	1.32/0.65	ns, Min
T <sub>RCKC_INJECTBITERR</sub> / T <sub>RCKC_INJECTBITERR</sub>	Inject single/double bit error in ECC mode	0.49/0.30	0.55/0.31	0.63/0.34	0.78/0.41	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM Enable (EN) input	0.30/0.17	0.33/0.18	0.38/0.20	0.48/0.22	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.21/0.13	0.25/0.13	0.31/0.14	0.34/0.16	ns, Min
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	Synchronous RSTREG input	0.25/0.06	0.27/0.06	0.29/0.06	0.35/0.06	ns, Min

## DSP48E1 Switching Characteristics

Table 32: DSP48E1 Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup and Hold Times of Data/Control Pins to the Input Register Clock</b>						
T <sub>DSPDCK_A_AREG</sub> /T <sub>DSPCKD_A_AREG</sub>	A input to A register CLK	0.24/ 0.12	0.27/ 0.14	0.31/ 0.16	0.38/ 0.12	ns
T <sub>DSPDCK_B_BREG</sub> /T <sub>DSPCKD_B_BREG</sub>	B input to B register CLK	0.28/ 0.13	0.32/ 0.14	0.39/ 0.15	0.51/ 0.16	ns
T <sub>DSPDCK_C_CREG</sub> /T <sub>DSPCKD_C_CREG</sub>	C input to C register CLK	0.15/ 0.15	0.17/ 0.17	0.20/ 0.20	0.31/ 0.21	ns
T <sub>DSPDCK_D_DREG</sub> /T <sub>DSPCKD_D_DREG</sub>	D input to D register CLK	0.21/ 0.19	0.27/ 0.22	0.35/ 0.26	0.46/ 0.20	ns
T <sub>DSPDCK_ACIN_AREG</sub> /T <sub>DSPCKD_ACIN_AREG</sub>	ACIN input to A register CLK	0.21/ 0.12	0.24/ 0.14	0.27/ 0.16	0.31/ 0.12	ns
T <sub>DSPDCK_BCIN_BREG</sub> /T <sub>DSPCKD_BCIN_BREG</sub>	BCIN input to B register CLK	0.22/ 0.13	0.25/ 0.14	0.30/ 0.15	0.34/ 0.16	ns
<b>Setup and Hold Times of Data Pins to the Pipeline Register Clock</b>						
T <sub>DSPDCK_{A,B}_MREG_MULT</sub> / T <sub>DSPCKD_B_MREG_MULT</sub>	{A, B} input to M register CLK using multiplier	2.04/ -0.01	2.34/ -0.01	2.79/ -0.01	3.66/ -0.06	ns
T <sub>DSPDCK_{A,B}_ADREG</sub> /T <sub>DSPCKD_D_ADREG</sub>	{A, D} input to AD register CLK	1.09/ -0.02	1.25/ -0.02	1.49/ -0.02	1.94/ -0.23	ns
<b>Setup and Hold Times of Data/Control Pins to the Output Register Clock</b>						
T <sub>DSPDCK_{A,B}_PREG_MULT</sub> / T <sub>DSPCKD_{A,B}_PREG_MULT</sub>	{A, B} input to P register CLK using multiplier	3.41/ -0.24	3.90/ -0.24	4.64/ -0.24	5.89/ -0.41	ns
T <sub>DSPDCK_D_PREG_MULT</sub> / T <sub>DSPCKD_D_PREG_MULT</sub>	D input to P register CLK using multiplier	3.33/ -0.62	3.81/ -0.62	4.53/ -0.62	5.70/ -1.42	ns
T <sub>DSPDCK_{A,B}_PREG</sub> / T <sub>DSPCKD_{A,B}_PREG</sub>	A or B input to P register CLK not using multiplier	1.47/ -0.24	1.68/ -0.24	2.00/ -0.24	2.37/ -0.41	ns
T <sub>DSPDCK_C_PREG</sub> /T <sub>DSPCKD_C_PREG</sub>	C input to P register CLK not using multiplier	1.30/ -0.22	1.49/ -0.22	1.78/ -0.22	2.11/ -0.36	ns
T <sub>DSPDCK_PCIN_PREG</sub> /T <sub>DSPCKD_PCIN_PREG</sub>	PCIN input to P register CLK	1.12/ -0.13	1.28/ -0.13	1.52/ -0.13	1.81/ -0.21	ns
<b>Setup and Hold Times of the CE Pins</b>						
T <sub>DSPDCK_{CEA;CEB}_{AREG;BREG}</sub> / T <sub>DSPCKD_{CEA;CEB}_{AREG;BREG}</sub>	{CEA; CEB} input to {A; B} register CLK	0.30/ 0.05	0.36/ 0.06	0.44/ 0.09	0.55/ 0.09	ns
T <sub>DSPDCK_CEC_CREG</sub> /T <sub>DSPCKD_CEC_CREG</sub>	CEC input to C register CLK	0.24/ 0.08	0.29/ 0.09	0.36/ 0.11	0.43/ 0.11	ns
T <sub>DSPDCK_CED_DREG</sub> /T <sub>DSPCKD_CED_DREG</sub>	CED input to D register CLK	0.31/ -0.02	0.36/ -0.02	0.44/ -0.02	0.58/ 0.12	ns
T <sub>DSPDCK_CEM_MREG</sub> /T <sub>DSPCKD_CEM_MREG</sub>	CEM input to M register CLK	0.26/ 0.15	0.29/ 0.17	0.33/ 0.20	0.39/ 0.25	ns
T <sub>DSPDCK_CEP_PREG</sub> /T <sub>DSPCKD_CEP_PREG</sub>	CEP input to P register CLK	0.31/ 0.01	0.36/ 0.01	0.45/ 0.01	0.54/ 0.00	ns

Table 32: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Clock to Outs from Pipeline Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_MREG</sub>	CLK MREG to P output	1.42	1.64	1.96	2.31	ns
T <sub>DSPCKO_CARRYCASCOU_MREG</sub>	CLK MREG to CARRYCASCOU output	1.63	1.87	2.24	2.65	ns
T <sub>DSPCKO_P_ADREG_MULT</sub>	CLK ADREG to P output using multiplier	2.30	2.63	3.13	3.90	ns
T <sub>DSPCKO_CARRYCASCOU_ADREG_MULT</sub>	CLK ADREG to CARRYCASCOU output using multiplier	2.51	2.87	3.41	4.23	ns
<b>Clock to Outs from Input Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_AREG_MULT</sub>	CLK AREG to P output using multiplier	3.34	3.83	4.55	5.80	ns
T <sub>DSPCKO_P_BREG</sub>	CLK BREG to P output not using multiplier	1.39	1.59	1.88	2.24	ns
T <sub>DSPCKO_P_CREG</sub>	CLK CREG to P output not using multiplier	1.43	1.64	1.95	2.32	ns
T <sub>DSPCKO_P_DREG_MULT</sub>	CLK DREG to P output using multiplier	3.32	3.80	4.51	5.74	ns
<b>Clock to Outs from Input Register Clock to Cascading Output Pins</b>						
T <sub>DSPCKO_{ACOUT; BCOUT}_{AREG; BREG}</sub>	CLK (ACOUT, BCOUT) to {A,B} register output	0.55	0.62	0.74	0.87	ns
T <sub>DSPCKO_CARRYCASCOU_{AREG, BREG}_MULT</sub>	CLK (AREG, BREG) to CARRYCASCOU output using multiplier	3.55	4.06	4.84	6.13	ns
T <sub>DSPCKO_CARRYCASCOU_BREG</sub>	CLK BREG to CARRYCASCOU output not using multiplier	1.60	1.82	2.16	2.58	ns
T <sub>DSPCKO_CARRYCASCOU_DREG_MULT</sub>	CLK DREG to CARRYCASCOU output using multiplier	3.52	4.03	4.79	6.07	ns
T <sub>DSPCKO_CARRYCASCOU_CREG</sub>	CLK CREG to CARRYCASCOU output	1.64	1.88	2.23	2.65	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	With all registers used	741.84	650.20	547.95	429.37	MHz
F <sub>MAX_PATDET</sub>	With pattern detector	627.35	549.75	463.61	365.90	MHz
F <sub>MAX_MULT_NOMREG</sub>	Two register multiply without MREG	412.20	360.75	303.77	248.32	MHz
F <sub>MAX_MULT_NOMREG_PATDET</sub>	Two register multiply without MREG with pattern detect	374.25	327.65	276.01	225.73	MHz
F <sub>MAX_PREADD_MULT_NOADREG</sub>	Without ADREG	468.82	408.66	342.70	263.44	MHz
F <sub>MAX_PREADD_MULT_NOADREG_PATDET</sub>	Without ADREG with pattern detect	468.82	408.66	342.70	263.44	MHz
F <sub>MAX_NOPIPELINEREG</sub>	Without pipeline registers (MREG, ADREG)	306.84	267.81	225.02	177.15	MHz
F <sub>MAX_NOPIPELINEREG_PATDET</sub>	Without pipeline registers (MREG, ADREG) with pattern detect	285.23	249.13	209.38	165.32	MHz

## Clock Buffers and Networks

Table 33: Global Clock Switching Characteristics (Including BUFGCTRL)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BCCCK_CE/T_BCCKC_CE <sup>(1)</sup>	CE pins Setup/Hold	0.12/0.30	0.14/0.38	0.26/0.38	0.23/0.40	ns
T_BCCCK_S/T_BCCKC_S <sup>(1)</sup>	S pins Setup/Hold	0.12/0.30	0.14/0.38	0.26/0.38	0.23/0.40	ns
T_BGCKO_O <sup>(2)</sup>	BUFGCTRL delay from I0/I1 to O	0.08	0.10	0.12	0.10	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFG</sub>	Global clock tree (BUFG)	741.00	710.00	625.00	560.00	MHz

**Notes:**

1. T<sub>BCCCK\_CE</sub> and T<sub>BCCKC\_CE</sub> must be satisfied to assure glitch-free operation of the global clock when switching between clocks. These parameters do not apply to the BUFGMUX primitive that assures glitch-free operation. The other global clock setup and hold times are optional; only needing to be satisfied if device operation requires simulation matches on a cycle-for-cycle basis when switching between clocks.
2. T<sub>BGCKO\_O</sub> (BUFG delay from I0 to O) values are the same as T<sub>BCCKO\_O</sub> values.

Table 34: Input/Output Clock Switching Characteristics (BUFIO)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BLOCKO_O	Clock to out delay from I to O	1.04	1.14	1.32	1.48	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFIO</sub>	I/O clock tree (BUFIO)	800.00	800.00	710.00	710.00	MHz

Table 35: Regional Clock Buffer Switching Characteristics (BUFR)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BRCKO_O	Clock to out delay from I to O	0.60	0.65	0.77	1.06	ns
T_BRCKO_O_BYP	Clock to out delay from I to O with Divide Bypass attribute set	0.30	0.32	0.38	0.57	ns
T_BRDO_O	Propagation delay from CLR to O	0.71	0.75	0.96	0.93	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFR</sub> <sup>(1)</sup>	Regional clock tree (BUFR)	600.00	540.00	450.00	450.00	MHz

**Notes:**

1. The maximum input frequency to the BUFR is the BUFIO F<sub>MAX</sub> frequency.

## Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

**Table 45: Global Clock Input Setup and Hold Without MMCM/PLL with ZHOLD\_DELAY on HR I/O Banks**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
$T_{PSFD}/T_{PHFD}$	Full Delay (Legacy Delay or Default Delay) Global Clock Input and IFF <sup>(2)</sup> without MMCM/PLL with ZHOLD_DELAY on HR I/O Banks	XC7K70T	2.83/-0.29	2.95/-0.29	3.15/-0.29	4.96/-0.33	ns	
		XC7K160T	3.17/-0.35	3.29/-0.35	3.55/-0.35	5.54/-0.49	ns	
		XC7K325T	2.83/-0.06	2.94/-0.06	3.15/-0.06	5.18/-0.14	ns	
		XC7K355T	3.26/-0.32	3.41/-0.32	3.67/-0.32	5.84/-0.49	ns	
		XC7K410T	3.43/-0.34	3.59/-0.34	3.88/-0.34	6.21/-0.54	ns	
		XC7K420T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns	
		XC7K480T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns	

### Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.

**Table 46: Clock-Capable Clock Input Setup and Hold With MMCM**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
$T_{PSMMCMCC}/T_{PHMMCMCC}$	No Delay clock-capable clock input and IFF <sup>(2)</sup> with MMCM	XC7K70T	2.39/-0.22	2.65/-0.22	2.94/-0.22	2.21/-0.44	ns	
		XC7K160T	2.49/-0.20	2.77/-0.20	3.07/-0.20	2.38/-0.47	ns	
		XC7K325T	2.55/-0.16	2.85/-0.16	3.14/-0.16	2.60/-0.47	ns	
		XC7K355T	2.43/-0.16	2.73/-0.16	3.00/-0.16	2.47/-0.43	ns	
		XC7K410T	2.55/-0.16	2.84/-0.16	3.14/-0.16	2.58/-0.47	ns	
		XC7K420T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns	
		XC7K480T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns	

### Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

## Additional Package Parameter Guidelines

The parameters in this section provide the necessary values for calculating timing budgets for Kintex-7 FPGA clock transmitter and receiver data-valid windows.

*Table 50: Package Skew*

Symbol	Description	Device	Package	Value	Units
$T_{PKGSKEW}$	Package Skew <sup>(1)</sup>	XC7K70T	FBG484	108	ps
			FBG676	135	ps
		XC7K160T	FBG484	118	ps
			FBG676	136	ps
			FFG676	161	ps
		XC7K325T	FBG676	146	ps
			FFG676	154	ps
			FBG900	163	ps
			FFG900	161	ps
		XC7K355T	FFG901	149	ps
		XC7K410T	FBG676	165	ps
			FFG676	168	ps
			FBG900	151	ps
			FFG900	146	ps
		XC7K420T	FFG901	149	ps
			FFG1156	145	ps
		XC7K480T	FFG901	149	ps
			FFG1156	145	ps

**Notes:**

1. These values represent the worst-case skew between any two SelectIO resources in the package: shortest delay to longest delay from die pad to ball.
2. Package delay information is available for these device/package combinations. This information can be used to deskew the package.

Table 53: GTX Transceiver Performance (Cont'd)

Symbol	Description	Output Divider	Speed Grade								Units	
			1.0V				0.9V					
			-3	-2/-2L	-1 <sup>(1)</sup>	-2L <sup>(2)</sup>						
			Package Type									
FF	FB	FF	FB	FF	FB	FF	FB	FF	FB	FF	GHz	
F <sub>GQPLL RANGE2</sub>	GTX transceiver QPLL frequency range 2		9.8–12.5	9.8–10.3125	N/A	N/A					GHz	

**Notes:**

1. The -1 speed grade requires a 4-byte internal data width for operation above 5.0 Gb/s.
2. The -2L (0.9V) speed grade requires a 4-byte internal data width for operation above 3.8 Gb/s.
3. Data rates between 8.0 Gb/s and 9.8 Gb/s are not available.
4. For QPLL line rate range 2, the maximum line rate with the divider N set to 66 is 10.3125Gb/s.

Table 54: GTX Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
F <sub>GTXDRPCLK</sub>	GTXDRPCLK maximum frequency	175.01	175.01	156.25	125.00	MHz	

Table 55: GTX Transceiver Reference Clock Switching Characteristics

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
F <sub>GCLK</sub>	Reference clock frequency range	-3 speed grade	60	—	700	MHz
		All other speed grades	60	—	670	MHz
T <sub>RCLK</sub>	Reference clock rise time	20% – 80%	—	200	—	ps
T <sub>FCLK</sub>	Reference clock fall time	80% – 20%	—	200	—	ps
T <sub>DCREF</sub>	Reference clock duty cycle	Transceiver PLL only	40	50	60	%

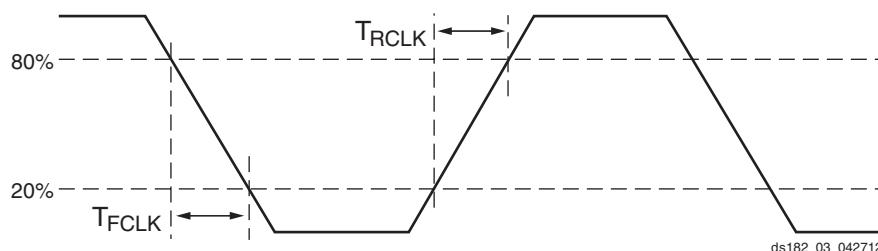


Figure 3: Reference Clock Timing Parameters

Table 56: GTX Transceiver PLL /Lock Time Adaptation

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
T <sub>LOCK</sub>	Initial PLL lock		—	—	1	ms
T <sub>DLOCK</sub>	Clock recovery phase acquisition and adaptation time for decision feedback equalizer (DFE).	After the PLL is locked to the reference clock, this is the time it takes to lock the clock data recovery (CDR) to the data present at the input.	—	50,000	37 x10 <sup>6</sup>	UI
	Clock recovery phase acquisition and adaptation time for low-power mode (LPM) when the DFE is disabled.		—	50,000	2.3 x10 <sup>6</sup>	UI

Table 57: GTX Transceiver User Clock Switching Characteristics<sup>(1)(2)</sup>

Symbol	Description	Conditions	Speed Grade				Units	
			1.0V		0.9V			
			-3 <sup>(3)</sup>	-2/-2L <sup>(3)</sup>	-1 <sup>(4)</sup>	-2L <sup>(5)</sup>		
F <sub>TXOUT</sub>	TXOUTCLK maximum frequency		412.54	412.54	312.50	237.53	MHz	
F <sub>RXOUT</sub>	RXOUTCLK maximum frequency		412.54	412.54	312.50	237.53	MHz	
F <sub>TXIN</sub>	TXUSRCLK maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz	
		32-bit data path	391.08	322.37	250.00	206.27	MHz	
F <sub>RXIN</sub>	RXUSRCLK maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz	
		32-bit data path	391.08	322.37	250.00	206.27	MHz	
F <sub>TXIN2</sub>	TXUSRCLK2 maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz	
		32-bit data path	391.08	322.37	250.00	206.27	MHz	
		64-bit data path	195.54	161.19	125.00	103.14	MHz	
F <sub>RXIN2</sub>	RXUSRCLK2 maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz	
		32-bit data path	391.08	322.37	250.00	206.27	MHz	
		64-bit data path	195.54	161.19	125.00	103.14	MHz	

**Notes:**

1. Clocking must be implemented as described in [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#).
2. These frequencies are not supported for all possible transceiver configurations.
3. For speed grades -3, -2, -2L (1.0V), a 16-bit data path can only be used for speeds less than 6.6 Gb/s.
4. For speed grade -1, a 16-bit data path can only be used for speeds less than 5.0 Gb/s.
5. For speed grade -2L (0.9V), a 16-bit data path can only be used for speeds less than 3.8 Gb/s.

Table 58: GTX Transceiver Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Typ	Max	Units
F <sub>GTXTX</sub>	Serial data rate range		0.500	—	F <sub>GTXMAX</sub>	Gb/s
T <sub>RTX</sub>	TX Rise time	20%–80%	—	40	—	ps
T <sub>FTX</sub>	TX Fall time	80%–20%	—	40	—	ps
T <sub>LLSKEW</sub>	TX lane-to-lane skew <sup>(1)</sup>		—	—	500	ps
V <sub>TXOOBVDP</sub>	Electrical idle amplitude		—	—	15	mV
T <sub>TXOOBTTRANSITION</sub>	Electrical idle transition time		—	—	140	ns
TJ <sub>12.5</sub>	Total Jitter <sup>(2)(4)</sup>	12.5 Gb/s	—	—	0.28	UI
DJ <sub>12.5</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>11.18</sub>	Total Jitter <sup>(2)(4)</sup>	11.18 Gb/s	—	—	0.28	UI
DJ <sub>11.18</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI

Table 58: GTX Transceiver Transmitter Switching Characteristics (Cont'd)

Symbol	Description	Condition	Min	Typ	Max	Units
TJ <sub>10.3125</sub>	Total Jitter <sup>(2)(4)</sup>	10.3125 Gb/s	—	—	0.28	UI
DJ <sub>10.3125</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>9.953</sub>	Total Jitter <sup>(2)(4)</sup>	9.953 Gb/s	—	—	0.28	UI
DJ <sub>9.953</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>9.8</sub>	Total Jitter <sup>(2)(4)</sup>	9.8 Gb/s	—	—	0.28	UI
DJ <sub>9.8</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>8.0</sub>	Total Jitter <sup>(2)(4)</sup>	8.0 Gb/s	—	—	0.30	UI
DJ <sub>8.0</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.15	UI
TJ <sub>6.6_QPLL</sub>	Total Jitter <sup>(2)(4)</sup>	6.6 Gb/s	—	—	0.28	UI
DJ <sub>6.6_QPLL</sub>	Deterministic Jitter <sup>(2)(4)</sup>		—	—	0.17	UI
TJ <sub>6.6_CPLL</sub>	Total Jitter <sup>(3)(4)</sup>	6.6 Gb/s	—	—	0.30	UI
DJ <sub>6.6_CPLL</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>5.0</sub>	Total Jitter <sup>(3)(4)</sup>	5.0 Gb/s	—	—	0.30	UI
DJ <sub>5.0</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>4.25</sub>	Total Jitter <sup>(3)(4)</sup>	4.25 Gb/s	—	—	0.30	UI
DJ <sub>4.25</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>3.75</sub>	Total Jitter <sup>(3)(4)</sup>	3.75 Gb/s	—	—	0.30	UI
DJ <sub>3.75</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.15	UI
TJ <sub>3.2</sub>	Total Jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(5)</sup>	—	—	0.2	UI
DJ <sub>3.2</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.1	UI
TJ <sub>3.2L</sub>	Total Jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(6)</sup>	—	—	0.32	UI
DJ <sub>3.2L</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.16	UI
TJ <sub>2.5</sub>	Total Jitter <sup>(3)(4)</sup>	2.5 Gb/s <sup>(7)</sup>	—	—	0.20	UI
DJ <sub>2.5</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.08	UI
TJ <sub>1.25</sub>	Total Jitter <sup>(3)(4)</sup>	1.25 Gb/s <sup>(8)</sup>	—	—	0.15	UI
DJ <sub>1.25</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.06	UI
TJ <sub>500</sub>	Total Jitter <sup>(3)(4)</sup>	500 Mb/s	—	—	0.1	UI
DJ <sub>500</sub>	Deterministic Jitter <sup>(3)(4)</sup>		—	—	0.03	UI

**Notes:**

1. Using same REFCLK input with TX phase alignment enabled for up to 12 consecutive transmitters (three fully populated GTX Quads).
2. Using QPLL\_FBDIV = 40, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
3. Using CPLL\_FBDIV = 2, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
4. All jitter values are based on a bit-error ratio of  $1e^{-12}$ .
5. CPLL frequency at 3.2 GHz and TXOUT\_DIV = 2.
6. CPLL frequency at 1.6 GHz and TXOUT\_DIV = 1.
7. CPLL frequency at 2.5 GHz and TXOUT\_DIV = 2.
8. CPLL frequency at 2.5 GHz and TXOUT\_DIV = 4.

Table 63: CEI-6G and CEI-11G Protocol Characteristics

Description	Line Rate (Mb/s)	Interface	Min	Max	Units
<b>CEI-6G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(1)</sup>	4976–6375	CEI-6G-SR	–	0.3	UI
		CEI-6G-LR	–	0.3	UI
<b>CEI-6G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(1)</sup>	4976–6375	CEI-6G-SR	0.6	–	UI
		CEI-6G-LR	0.95	–	UI
<b>CEI-11G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(2)</sup>	9950–11100	CEI-11G-SR	–	0.3	UI
		CEI-11G-LR/MR	–	0.3	UI
<b>CEI-11G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(2)</sup>	9950–11100	CEI-11G-SR	0.65	–	UI
		CEI-11G-MR	0.65	–	UI
		CEI-11G-LR	0.825	–	UI

**Notes:**

1. Tested at most commonly used line rate of 6250 Mb/s using 390.625 MHz reference clock.
2. Tested at line rate of 9950 Mb/s using 155.46875 MHz reference clock and 11100 Mb/s using 173.4375 MHz reference clock.

Table 64: SFP+ Protocol Characteristics

Description	Line Rate (Mb/s)	Min	Max	Units
<b>SFP+ Transmitter Jitter Generation</b>				
Total transmitter jitter	9830.40 <sup>(1)</sup>	–	0.28	UI
	9953.00			
	10312.50			
	10518.75			
	11100.00			
<b>SFP+ Receiver Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	9830.40 <sup>(1)</sup>	0.7	–	UI
	9953.00			
	10312.50			
	10518.75			
	11100.00			

**Notes:**

1. Line rated used for CPRI over SFP+ applications.

Table 67: XADC Specifications (Cont'd)

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
<b>XADC Reference<sup>(5)</sup></b>						
External Reference	V <sub>REFP</sub>	Externally supplied reference voltage	1.20	1.25	1.30	V
On-Chip Reference		Ground V <sub>REFP</sub> pin to AGND, T <sub>j</sub> = -40°C to 100°C	1.2375	1.25	1.2625	V

**Notes:**

- Offset and gain errors are removed by enabling the XADC automatic gain calibration feature. The values are specified for when this feature is enabled.
- Only specified for new BitGen option XADCEnhancedLinearity = ON.
- See the ADC chapter in [UG480: 7 Series FPGAs XADC User Guide](#) for a detailed description.
- See the Timing chapter in [UG480: 7 Series FPGAs XADC User Guide](#) for a detailed description.
- Any variation in the reference voltage from the nominal V<sub>REFP</sub> = 1.25V and V<sub>REFN</sub> = 0V will result in a deviation from the ideal transfer function. This also impacts the accuracy of the internal sensor measurements (i.e., temperature and power supply). However, for external ratiometric type applications allowing reference to vary by ±4% is permitted. On-chip reference variation is ±1%.

## Configuration Switching Characteristics

Table 68: Configuration Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Power-up Timing Characteristics</b>						
T <sub>PL</sub> <sup>(1)</sup>	Program latency	5	5	5	5	ms, Max
T <sub>POR</sub> <sup>(1)</sup>	Power-on reset (50 ms ramp rate time)	10/50	10/50	10/50	10/50	ms, Min/Max
	Power-on reset (1 ms ramp rate time)	10/35	10/35	10/35	10/35	ms, Min/Max
T <sub>PROGRAM</sub>	Program pulse width	250	250	250	250	ns, Min
<b>CCLK Output (Master Mode)</b>						
T <sub>ICCK</sub>	Master CCLK output delay	150	150	150	150	ns, Min
T <sub>MCCKL</sub>	Master CCLK clock Low time duty cycle	40/60	40/60	40/60	40/60	%, Min/Max
T <sub>MCCKH</sub>	Master CCLK clock High time duty cycle	40/60	40/60	40/60	40/60	%, Min/Max
F <sub>MCCCK</sub>	Master CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
	Master CCLK frequency for AES encrypted x16	50.00	50.00	50.00	35.00	MHz, Max
F <sub>MCCK_START</sub>	Master CCLK frequency at start of configuration	3.00	3.00	3.00	3.00	MHz, Typ
F <sub>MCCKTOL</sub>	Frequency tolerance, master mode with respect to nominal CCLK	±50	±50	±50	±50	%, Max
<b>CCLK Input (Slave Modes)</b>						
T <sub>SCCKL</sub>	Slave CCLK clock minimum Low time	2.50	2.50	2.50	2.50	ns, Min
T <sub>SCCKH</sub>	Slave CCLK clock minimum High time	2.50	2.50	2.50	2.50	ns, Min
F <sub>SCCK</sub>	Slave CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>EMCCLK Input (Master Mode)</b>						
T <sub>EMCCKL</sub>	External master CCLK Low time	2.50	2.50	2.50	2.50	ns, Min
T <sub>EMCCKH</sub>	External master CCLK High time	2.50	2.50	2.50	2.50	ns, Min
F <sub>EMCCK</sub>	External master CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Internal Configuration Access Port</b>						
F <sub>ICAPCK</sub>	Internal configuration access port (ICAPE2)	100.00	100.00	100.00	70.00	MHz, Max

## Revision History

The following table shows the revision history for this document:

Date	Version	Description
03/01/11	1.0	Initial Xilinx release.
04/01/11	1.1	Added the XC7K355T, XC7K420T, and XC7K480T devices throughout data sheet. Added the extended temperature range discussion to <a href="#">page 1</a> . Updated $V_{CCAUX\_IO}$ in <a href="#">Table 2</a> . Edits to clarify <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion. Added $I_{CCAUX\_IO}$ and $I_{CCBRAM}$ to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated MMCM_ $F_{INDUTY}$ and added $F_{INJITTER}$ , $T_{OUTJITTER}$ , $T_{EXTFDVAR}$ , and <a href="#">Note 3</a> to <a href="#">Table 38</a> . Removed the SBG324 package from <a href="#">Table 50</a> . Updated the <a href="#">Notice of Disclaimer</a> .
10/04/11	1.2	Replaced -1L with -2L throughout this data sheet. Updated Min/Max values and removed Note 5 from <a href="#">Table 2</a> . Clarified <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion including adding $T_{VCO2VCCAUX}$ to <a href="#">Table 8</a> . Updated $V_{ICM}$ in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Added Note 1 to table 12. Updated <a href="#">Table 69</a> including adding <a href="#">Note 1</a> . Added <i>Absolute Maximum Ratings for GTX Transceivers</i> . Revised the reference clock maximum frequency ( $F_{GCLK}$ ) in <a href="#">Table 55</a> . Added <a href="#">Table 57</a> . Added LVTTL and removed SSTL135_II and SSTL15_II specifications from <a href="#">Table 19</a> . Removed HSTL_III from <a href="#">Table 20</a> . Removed the <i>I/O Standard Adjustment Measurement Methodology</i> section. Use IBIS for more accurate information and measurements. Updated $T_{IDELAYPAT\_JIT}$ in <a href="#">Table 26</a> . Added $T_{AS}/T_{AH}$ to <a href="#">Table 28</a> . Added $T_{RDCK\_DI\_WF\_NC}/T_{RCKD\_DI\_WF\_NC}$ and $T_{RDCK\_DI\_RF}/T_{RCKD\_DI\_RF}$ to <a href="#">Table 31</a> . Completely updated <a href="#">Table 68</a> . Updated the <a href="#">AC Switching Characteristics</a> in <a href="#">Table 19</a> , <a href="#">Table 20</a> , <a href="#">Table 21</a> , <a href="#">Table 22</a> , <a href="#">Table 23</a> , <a href="#">Table 24</a> , <a href="#">Table 26</a> through <a href="#">Table 38</a> , <a href="#">Table 40</a> though <a href="#">Table 37</a> , and <a href="#">Table 67</a> .
11/03/11	1.3	Revised the $V_{OCM}$ specification in <a href="#">Table 12</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.3 v1.02 speed specification throughout document including <a href="#">Table 19</a> and <a href="#">Table 20</a> . Added MMCM_ $T_{FBDELAY}$ while adding MMCM_ to the symbol names of a few specifications in <a href="#">Table 38</a> and PLL to the symbol names in <a href="#">Table 39</a> . In <a href="#">Table 40</a> through <a href="#">Table 47</a> , updated the pin-to-pin descriptions with the SSTL15 standard. Updated units in <a href="#">Table 49</a> .
02/13/12	1.4	Updated summary description on <a href="#">page 1</a> . In <a href="#">Table 2</a> , revised $V_{CCO}$ for the 3.3V HR I/O banks and updated $T_j$ . Added typical values to <a href="#">Table 3</a> . Updated the notes in <a href="#">Table 6</a> . Added MGTAVCC, MGTAVTT, and MGTVCCAUX power supply ramp times to <a href="#">Table 8</a> . Rearranged <a href="#">Table 9</a> , added Mobile_DDR, HSTL_I_18, HSTL_II_18, HSUL_12, SSTL135_R, SSTL15_R, and SSTL12 and removed DIFF_SSTL135, DIFF_SSTL18_I, DIFF_SSTL18_II, DIFF_HSTL_I, and DIFF_HSTL_II. Added <a href="#">Table 10</a> and <a href="#">Table 11</a> . Revised the specifications in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Updated the <a href="#">eFUSE Programming Conditions</a> section and removed the endurance table. Added the <a href="#">IO_FIFO</a> <a href="#">Switching Characteristics</a> table. Revised $I_{CCADC}$ and updated <a href="#">Note 1</a> in <a href="#">Table 67</a> . Revised DDR LVDS transmitter data width in <a href="#">Table 16</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.4 v1.03 speed specification throughout document. Removed notes from <a href="#">Table 28</a> as they are no longer applicable. Updated specifications in <a href="#">Table 68</a> . Updated <a href="#">Note 1</a> in <a href="#">Table 37</a> . In the <a href="#">GTX Transceiver DC Input and Output Levels</a> section: Revised $V_{IN}$ , and added $I_{DCIN}$ and $I_{DCOUT}$ to <a href="#">Table 51</a> . Added <a href="#">Note 4</a> to <a href="#">Table 53</a> . In <a href="#">Table 55</a> , revised $F_{GCLK}$ , removed $T_{PHASE}$ , and added $T_{DLOCK}$ . Revised specifications and added <a href="#">Note 2</a> to <a href="#">Table 57</a> . Added <a href="#">Table 58</a> and <a href="#">Table 59</a> along with <a href="#">GTX Transceiver Protocol Jitter Characteristics</a> in <a href="#">Table 60</a> through <a href="#">Table 65</a> .
05/23/12	1.5	Reorganized entire data sheet including adding <a href="#">Table 44</a> and <a href="#">Table 48</a> . Updated $T_{SOL}$ in <a href="#">Table 1</a> . Updated $I_{BATT}$ and added $R_{IN\_TERM}$ to <a href="#">Table 3</a> . Added values to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated <a href="#">Power-On/Off Power Supply Sequencing</a> , <a href="#">page 6</a> with regards to GTX transceivers. Updated many parameters in <a href="#">Table 9</a> including SSTL135 and SSTL135_R. Removed $V_{OX}$ column and added DIFF_HSUL_12 to <a href="#">Table 11</a> . Updated $V_{OL}$ in <a href="#">Table 12</a> . Updated <a href="#">Table 16</a> and removed notes 2 and 3. Updated <a href="#">Table 17</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 14.1 v1.04 for the -3, -2, -2L (1.0V), -1, and -2L (0.9V) speed specifications throughout the document. In <a href="#">Table 31</a> , updated <a href="#">Reset Delays</a> section including <a href="#">Note 10</a> and <a href="#">Note 11</a> . Added data for $T_{LOCK}$ and $T_{DLOCK}$ in <a href="#">Table 55</a> . Updated many of the XADC specifications in <a href="#">Table 67</a> and added <a href="#">Note 2</a> . Updated and moved <i>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</i> section from <a href="#">Table 68</a> to <a href="#">Table 38</a> and <a href="#">Table 39</a> .